

**Notice of References Cited**

Application/Control No.

10/551,553

Applicant(s)/Patent Under  
Reexamination  
TANAKA, TOSHIHIKO

Examiner

Jonathan Jelsma

Art Unit

1795

Page 1 of 1

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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